Technical Specifications

Agilent Technologies PNA Series Network Analyzers N3381A, N3382A, N3383A

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Technical Specifications for the N3381A, N3382A, N3383A

Definitions	2
Corrected System Performance	3
Table 1. System Dynamic Range	3
Corrected System Performance with Type-N Connectors	4
Table 2. Corrected System Performance With 85032F Calibration Kit	4
Table 3. Corrected System Performance With 85092C ECal Module	5
Corrected System Performance with 3.5 mm Connectors	6
Table 4. Corrected System Performance With 85033E Calibration Kit	6
Table 5. Corrected System Performance With 85093C Ecal Module	7
Table 6. Corrected System Performance With 85038A Calibration Kit	8
Table 7. Uncorrected Instrument Performance	9
Test Port Output Characteristics (Source)	9
Table 8. Test Port Output Frequency	9
Table 9. Test Port Output Power	10
Table 10. Test Port Output Signal Purity	10
Test Port and Receiver Input Characteristics	11
Table 11. Test Port and Receiver Input Levels	11
Table 11. Test Port and Receiver Input Levels	12
Table 12. Test Port Input (Trace Noise)	12
Table 13. Test Port Input (Reference Level and Stability)	13
Table 14. Test Port Input (Dynamic Accuracy specification)	14
Table 15. Test Port Input (Group Delay)	15
General Information	15
Table 16. System Bandwidths	15
Table 17. Front Panel Information	16
Table 18. Rear Panel Information	17
Table 19. Rear Panel Information (continued)	18
Table 20. Analyzer Environment and Dimensions	19
Measurement Throughput Summary	20
Table 21. Typical Cycle Time (ms)	20
Table 22. Cycle Time vs. IF Bandwidth	20
Table 23. Cycle Time vs. Number of Points ^a	21
Table 24. Data Transfer Timea (ms)	22
Table 25. Recall and Sweep Speed	23
N3381A, N3382A, and N3383A Simplified Test Set Block Diagram	24
N3381A, N3382A, and N3383A with Ontion 014 Simplified Test Set Block Diagram	25

This is a complete list of the N3381A, N3382A, and N3383A network analyzer technical specifications.

- To optimize viewing of uncertainty curves, click the Maximize button.
- To view or print the PNA Series Data Sheet (a condensed version of the specifications), visit our web site at http://www.agilent.com/find/pna, select your analyzer model, and click on the link for the data sheet.
- The uncertainty curves contained in this document apply only to the setup conditions listed. Please download our free Uncertainty Calculator from http://www.agilent.com/find/na_calculator to generate the curves for your PNA setup. View the equations used to generate the uncertainty curves.

Definitions

All specifications and characteristics apply over a 25 °C ±5 °C range (unless otherwise stated) and 90 minutes after the instrument has been turned on.

Specification (spec.): Warranted performance. Specifications include guardbands to account for the expected statistical performance distribution, measurement uncertainties, and changes in performance due to environmental conditions.

Characteristic (char.): A performance parameter that the product is expected to meet before it leaves the factory, but that is not verified in the field and is not covered by the product warranty. A characteristic includes the same guardbands as a specification.

Typical (typ.): Expected performance of an average unit which does not include guardbands. It is not covered by the product warranty.

Nominal (nom.): A general, descriptive term that does not imply a level of performance. It is not covered by the product warranty.

Calibration: The process of measuring known standards to characterize a network analyzer's systematic (repeatable) errors.

Corrected (residual): Indicates performance after error correction (calibration). It is determined by the quality of calibration standards and how well "known" they are, plus system repeatability, stability, and noise.

Uncorrected (raw): Indicates instrument performance without error correction. The uncorrected performance affects the stability of a calibration.

Standard: When referring to the analyzer, this includes no options unless noted otherwise.

Corrected System Performance

Note: This document provides technical specifications for the following calibration kits only: 85032F, 85092C, 85033E, 85093C and 85038A.

The specifications in this section apply for measurements made with the N3381A, N3382A, and N3383A analyzer with the following conditions:

- 10 Hz IF bandwidth
- No averaging applied to data
- Environmental temperature of 25 °C ±5 °C, with < 1 °C deviation from calibration temperature
- Isolation calibration not omitted

Table 1. System Dynamic Range

Description	Specification (dB)	Characteristic (dB)					
	Dynamic range ^a (at test port)						
300 kHz to 25 MHz ^b	125						
25 MHz to 3 GHz ^b	128						
3 GHz to 6 GHz	118						
6 GHz to 9 GHz	115						
Dynamic range ^c (at rec	ceiver input)						
300 kHz to 25 MHz ^d		140					
25 MHz to 3 GHz ^d		143					
3 GHz to 6 GHz		133					
6 GHz to 9 GHz		130					

^a The test port dynamic range is calculated as the difference between the test port rms noise floor and the source maximum output power. The effective dynamic range must take measurement uncertainties and interfering signals into account.

Note: Receiver Dynamic Range specifications are not included in this N3381/2/3A document.

^b May be limited to 100 dB at particular frequencies below 750 MHz due to spurious receiver residuals.

The receiver input dynamic range is calculated as the difference between the receiver rms noise floor and the source maximum output power. The effective dynamic range must take measurement uncertainties and interfering signals into account. This set-up should only be used when the receiver input will never exceed its damage level. When the analyzer is in segment sweep mode, frequency segments can be defined with a higher power level when the extended dynamic range is required (i.e. the portion of the device's response with high insertion loss), and reduced power when receiver damage may occur (i.e. the portion of the devices's response with low insertion loss). Specification applies only when power is sourced from Port 1. If power is sourced from either Port 2 or Port 3, dynamic range decreases by 3 dB.

May be limited to 115 dB at particular frequencies below 750 MHz due to spurious receiver residuals.

Corrected System Performance with Type-N Connectors

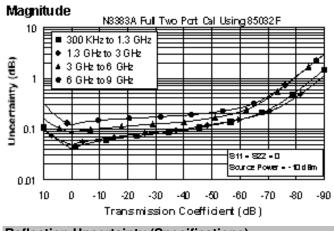
Table 2. Corrected System Performance With Type-N Device Connectors, 85032F Calibration Kit

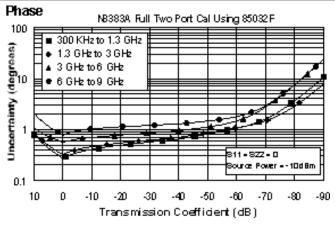
Applies to the N3381A, N3382A, and N3383A analyzer, 85032F (Type-N, 50Ω) calibration kit, N6314A test port cable, and a full 2-port calibration. Also applies to the following conditions:

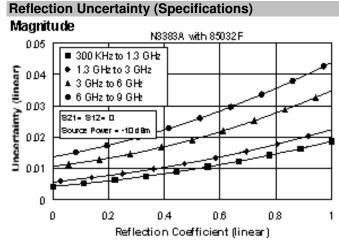
- IF bandwidth = 10 Hz
- No averaging applied to data
- Environmental temperature 25° ±5 °C, with < 1 °C deviation from calibration temperature
- Isolation calibration not omitted

Description	Specification (dB)			
	300 kHz to	1.3 GHz to	3 to	6 to
	1.3 GHz	3 GHz	6 GHz	9 GHz
Directivity	49	46	40	38
Source Match	41	40	36	35
Load Match	49	45	39	37
Reflection Tracking	±0.011	±0.021	±0.032	±0.054
Transmission	±0.012	±0.020	±0.055	±0.083
Tracking				

Transmission Uncertainty (Specifications)







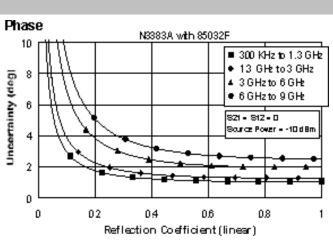


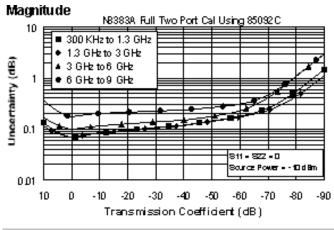
Table 3. Corrected System Performance With Type-N Device Connectors, 85092C Electronic Calibration Module

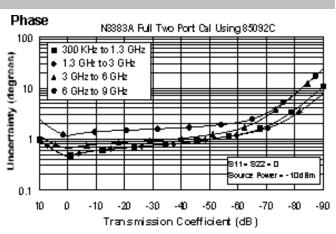
Applies to the N3381A, N3382A, and N3383A analyzer, 85092C (Type-N, 50Ω) electronic calibration (ECal) module, N6314A test port cable, and a full 2-port calibration. Also applies to the following conditions:

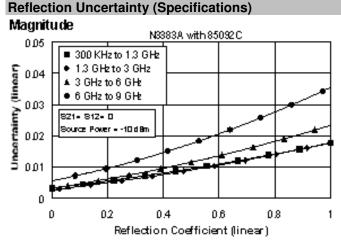
- IF bandwidth = 10 Hz
- No averaging applied to data
- Environmental temperature 25° ±5 °C, with < 1 °C deviation from calibration temperature
- Isolation calibration not omitted

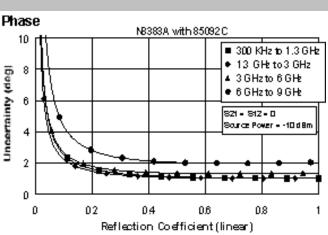
Description	Specification (dB)				
	300 kHz to	300 kHz to 1.3 GHz to 3 to 6 t		6 to	
	1.3 GHz	3 GHz	6 GHz	9 GHz ^a	
Directivity	52	54	52	47	
Source Match	45	44	41	36	
Load Match	47	47	44	39	
Reflection Tracking	±0.040	±0.040	±0.060	±0.070	
Transmission Tracking	±0.039	±0.039	±0.068	±0.136	

Transmission Uncertainty (Specifications)









Corrected System Performance with 3.5 mm Connectors

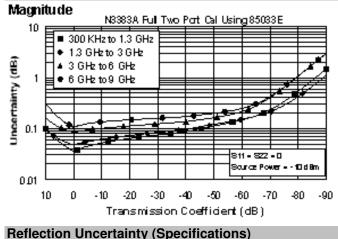
Table 4. Corrected System Performance With 3.5 mm Device Connector Type, 85033E **Calibration Kit**

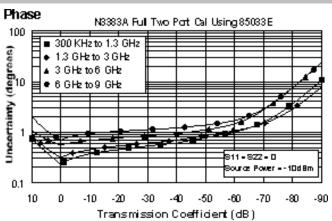
Applies to the N3381A, N3382A, and N3383A analyzer, 85033E (3.5 mm, 50Ω) calibration kit, N6314A test port cable, and a full 2-port calibration. Also applies to the following conditions:

- IF bandwidth = 10 Hz
- No averaging applied to data
- Environmental temperature 25° ±5 °C, with < 1 °C deviation from calibration temperature
- Isolation calibration not omitted

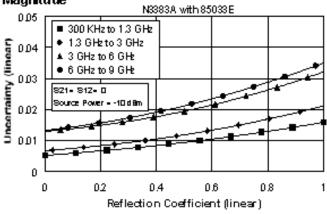
Description	Specification (dB)			
	300 kHz to	1.3 GHz to	3 to	6 to
	1.3 GHz	3 GHz	6 GHz	9 GHz
Directivity	46	44	38	38
Source Match	43	40	37	36
Load Match	46	44	38	38
Reflection Tracking	±0.006	±0.007	±0.009	±0.010
Transmission Tracking	±0.012	±0.021	±0.057	±0.075

Transmission Uncertainty (Specifications)





Magnitude N3383A with 85033E 0.05



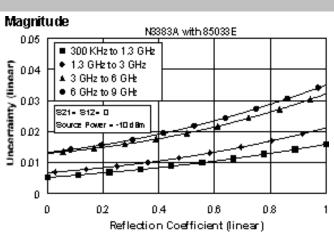


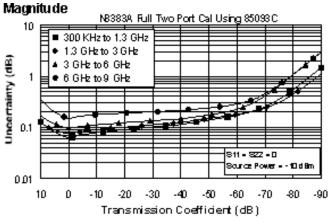
Table 5. Corrected System Performance With 3.5 mm Device Connector Type, 85093C Electronic Calibration Module

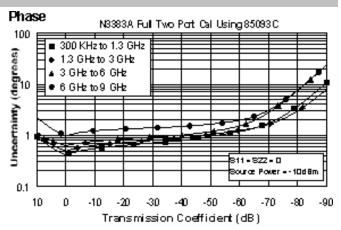
Applies to the N3381A, N3382A, and N3383A analyzer, 85093C (3.5 mm, 50Ω) electronic calibration (ECal) module, N6314A test port cable, and a full 2-port calibration. Also applies to the following conditions:

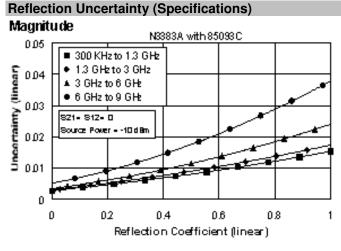
- IF bandwidth = 10 Hz
- No averaging applied to data
- Environmental temperature 25° ±5 °C, with < 1 °C deviation from calibration temperature
- Isolation calibration not omitted

Description	Specification (dB)			
	300 kHz to 1.3 GHz to 3 to 6 to		6 to	
	1.3 GHz	3 GHz	6 GHz	9 GHz ^a
Directivity	52	52	51	47
Source Match	44	44	39	34
Load Match	47	47	44	40
Reflection Tracking	±0.030	±0.040	±0.050	±0.070
Transmission Tracking	±0.039	±0.049	±0.068	±0.117

Transmission Uncertainty (Specifications)







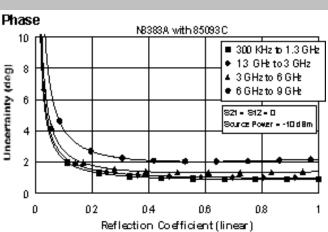


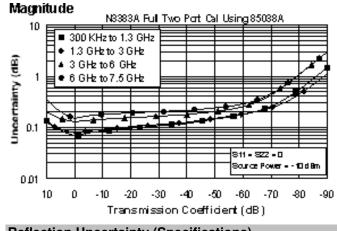
Table 6. Corrected System Performance With 7-16 Device Connector Type, 85038A Calibration Kit

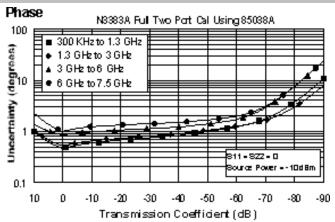
Applies to the N3381A, N3382A, and N3383A analyzer, 85038A (7-16, 50Ω) calibration kit, N6314A test port cable, and a full 2-port calibration. Also applies to the following conditions:

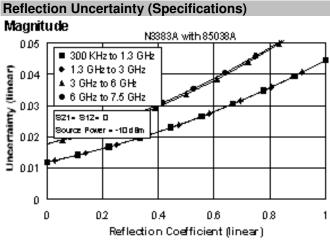
- IF bandwidth = 10 Hz
- No averaging applied to data
- Environmental temperature 25° ±5 °C, with < 1 °C deviation from calibration temperature
- Isolation calibration not omitted

Description	Specification	Specification (dB)			
	300 kHz to 1.3 GHz to 3 t		3 to	6 to	
	1.3 GHz	3 GHz	6 GHz	9 GHz ^a	
Directivity	40	40	36	36	
Source Match	37	37	34	34	
Load Match	39	39	35	35	
Reflection Tracking	±0.089	±0.089	±0.115	±0.115	
Transmission Tracking	±0.024	±0.033	±0.082	±0.103	

Transmission Uncertainty (Specifications)







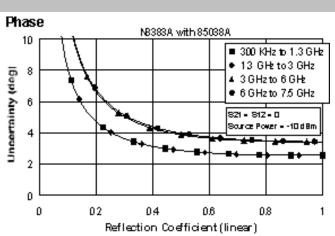


Table 7. Uncorrected Instrument Performance

Description	Specification	Specification (dB)			
	300 kHz to	1MHz to	1.3 GHz to	3 GHz to	6 GHz to
	1 MHz	1.3 GHz	3 GHz	6 GHz	9 GHz
Directivity	30	33	27	20	13
Source Match Ports 1 and 2	18	18	17	14	12
Source Match Port 3 only	18	18	17	14	12
Load Match Ports 1 and 2	20	20	17	13.5	11.5
Load Match Port 3 only	20	20	17	13.5	11.5
Reflection Tracking	±1.5	±1.5	±1.5	±2.5	±3.0
Transmission Tracking	±1.5	±1.5	±1.5	±2.5	±3.0

Test Port Output Characteristics (Source)

Table 8. Test Port Output Frequency

Description	Specification	Supplemental Information
Range:		
N3381A	300 kHz to 3.0 GHz	
N3382A	300 kHz to 6.0 GHz	
N3383A	300 kHz to 9.0 GHz	
Resolution	1 Hz	
Source Stability		±1 ppm, 0° to 40 °C, typical
		±1ppm/year maximum
Source Stability		±0.05 ppm, 0° to 40 °C, typical
(Option 1E5)		±0.1 ppm/year maximum
CW Accuracy	±3 ppm	
CW Accuracy		
(Option 1E5)	±1 ppm	

Table 9. Test Port Output Power^a

Description	Specification	Supplemental Information
Level Accuracy		
		Variation from 0 dBm in power range 0 (step attenuator at 0 dB) ±1.5dB below 10 MHz
300 kHz to 6 GHz	±1.0 dB	±1.3db below 10 lvii iz
6 GHz to 9 GHz	±2.0 dB	
Level Linearity		
		Variation from 0 dBm in power range 0
300 kHz to 9 GHz	±0.3 dB	-15 to +5 dBm
300 kHz to 1 MHz	±1.0 dB	+5 to +10 dBm
1 MHz to 6 GHz	±0.5 dB	+5 to +10 dBm
6 GHz to 9 GHz	±0.5 dB	+5 to +7 dBm
Range⁵		
300 kHz to 6 GHz	-15 to +10 dBm	
6 GHz to 9 GHz	-15 to +7 dBm	
Range ^b (Option 1E1)		
300 kHz to 6 GHz	-85 to +10 dBm	
6 GHz to 9 GHz	-85 to +7 dBm	
Sweep Range		
Port 1:		
300 kHz to 6 GHz	25 dB	
6 GHz to 9 GHz	22 dB	
Level Resolution	0.01 dB	

^a Source output performance on port 1 only. Port 2 and port 3 output performance is typically 3 dB less.

Table 10. Test Port Output Signal Purity

Description	Specification	Supplemental Information
Harmonics (2nd or 3rd)		
at max output power (< 25 MHz)		< -25 dBc, typical
at max output power (25 MHz to 9 GHz)		< -25 dBc, characteristic ^a
at 0 dBm output		< -35 dBc, typical
at -10 dBm output		< -38 dBc, typical, in power range 0
Non-harmonic Spurious		
at max output		-30 dBc, typical for offset freq>1kHz
at -10 dBm output		-50 dBc, typical for offset freq >1kHz

^a Typical below 25 MHz.

^b Power to which the source can be set and phase lock is assured.

Test Port and Receiver Input Characteristics

Table 11. Test Port and Receiver Input Levels

Description	Specification	Supplemental Information
Description Maximum Test Port Input L		Supplemental information
300 kHz to 25 MHz	+10 dBm	O.C. dD. compression
25 MHz to 3 GHz	+10 dBm	<0.6 dB compression
3 GHz to 6 GHz	+10 dBm	<0.4 dB compression
6 GHz to 9 GHz	+7 dBm	<0.7 dB compression
Damage Level	+/ UDIII	<0.7 dB compression
Test Port 1, 2. 3	T	+30 dBm or ±30 VDC, typ.
R, A, B, C (Opt. 014)		+15 dBm or ±5 VDC, typ.
Coupler Thru (Opt. 014)		+33 dBm or ±0 VDC, typ.
Test Port Noise Floor ^a		100 dB. 101 E0 120; typ.
300 kHz to 25 MHz ^b		
10 Hz IF Bandwidth	-115 dBm	
1 kHz IF Bandwidth	-95 dBm	
25 MHz to 3 GHz ^b		'
10 Hz IF Bandwidth	-118 dBm	
1 kHz IF Bandwidth	-98 dBm	
3 GHz to 9 GHz		
10 Hz IF Bandwidth	≤ -108 dBm	
1 kHz IF Bandwidth	≤ -88 dBm	
Receiver Noise Floor ^a		
300 kHz to 25 MHz ^c		
10 Hz IF Bandwidth	≤ -130 dBm,	
	characteristic	
1 kHz IF Bandwidth	≤ -110 dBm,	
	characteristic	
25 MHz to 3 GHz ^c		
10 Hz IF Bandwidth	-133 dBm,	
	characteristic	
1 kHz IF Bandwidth	-113 dBm,	
6 CHz to 0 CHz	characteristic	
6 GHz to 9 GHz	4 400 15	
10 Hz IF Bandwidth	≤ -123 dBm, characteristic	
1 kHz IF Bandwidth	≤ -103 dBm,	
NIZII Daliuwiutii	≤ -103 dBm, characteristic	
	orial acteriotic	

Table 11. Test Port and Receiver Input Levels

Description	Specification	Supplemental Information	
Crosstalk			
(S_{21}, S_{31}) :			
300 kHz to 1 MHz	<-120 dB		
1 MHz to 25 MHz	<-125 dB		
25 MHz to 3 GHz	<-126 dB		
3 GHz to 6 GHz	<-117 dB		
6 GHz to 9 GHz	<-106 dB		
(S ₁₂ , S ₁₃):		•	
300 kHz to 1 MHz	<-120 dB		
1 MHz to 25 MHz	<-125 dB		
25 MHz to 3 GHz	<-126 dB		
3 GHz to 6 GHz	<-113 dB		
6 GHz to 9 GHz	<-106 dB		
(S ₂₃ , S ₃₂):	•	•	
300 kHz to 1 MHz	<-120 dB		
1 MHz to 3 GHz	<-125 dB		
3 GHz to 6 GHz	<-115 dB		
6 GHz to 9 GHz	<-107 dB		
Maximum Receiver Input Level (A, B, R, C)			
300 kHz to 6 GHz		6 dBm, typical	
6 GHz to 9 GHz		9 dBm, typical	
Reference Input Level (R)d		•	
300 kHz to 9 GHz		-10 to -35 dBm, typical	
Maximum Coupler Input Level (Opt 014)			
300 kHz to 9 GHz		+33 dBm, typical	

^a Total average (RMS) noise power calculated as the mean value of a linear magnitude trace expressed in dBm.

Table 12. Test Port Input (Trace Noise)

14510 121 100t1 01tput (11400 110100)				
Specification	Supplemental Information			
< 0.002 dB rms				
< 0.005 dB rms				
< 0.010° rms				
< 0.035° rms				
	< 0.002 dB rms < 0.005 dB rms < 0.010° rms			

^a Trace noise is defined as a ratio measurement of a through or a full reflection, with the source set to 0 dBm.

^b May be limited to -90 dBm at particular frequencies below 750 MHz due to spurious receiver residuals.

^c May be limited to -105 dBm at particular frequencies below 750 MHz due to spurious receiver residuals.

^d Input level to maintain phase lock.

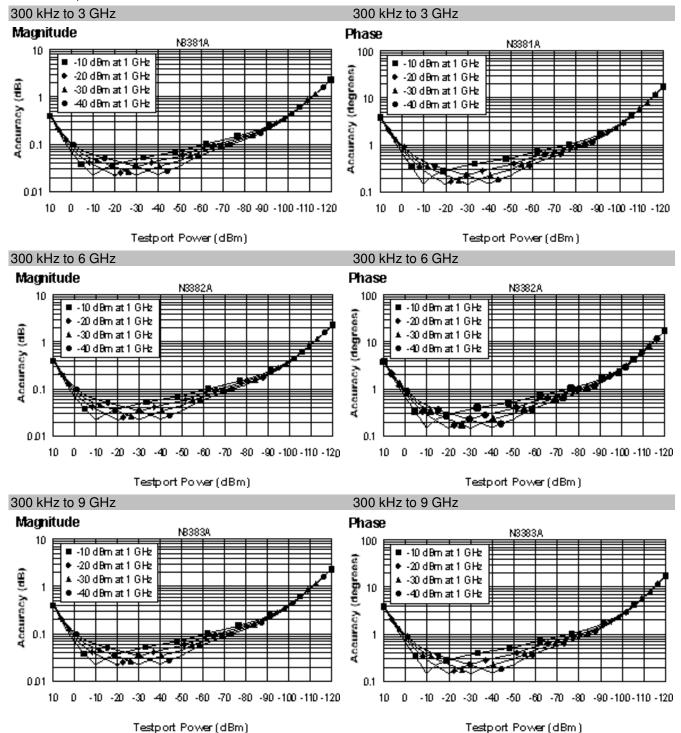
Table 13. Test Port Input (Reference Level and Stability)

Description	Specification	Supplemental Information	
Reference Level Magnitude			
Range	±200 dB		
Resolution	0.001 dB		
Reference Level Phase			
Range	±500°		
Resolution	0.01°		
Stability Magnitude ^a			
300 kHz to 3 GHz		0.02 dB/°C, typical	
3 GHz to 6 GHz		0.04 dB/°C, typical	
6 GHz to 9 GHz		0.06 dB/°C, typical	
Stability Phase ^a			
300 kHz to 3 GHz		0.2°/°C, typical	
3 GHz to 6 GHz		0.3°/°C, typical	
6 GHz to 9 GHz		0.6°/°C, typical	

^a Stability is defined as a ratio measurement at the test port.

Table 14. Test Port Input (Dynamic Accuracy specification^a)

Accuracy of the test port input power reading is relative to the reference input power level. Applies to input ports 1 and 2 with the following conditions: IF bandwidth = 10 Hz, and Environmental temperature 25° ±5 °C, with < 1 °C deviation from calibration temperature

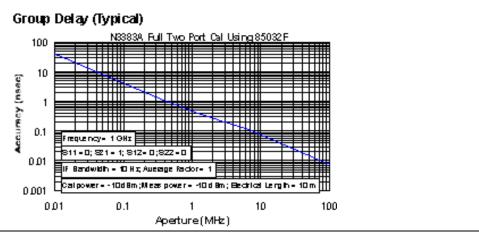


- ^aDynamic accuracy is verified with the following measurements:
 - compression over frequency
 - IF linearity at a single frequency of 1.195 GHz and a reference level of -20 dBm

Table 15. Test Port Input (Group Delay)^a

Description	Specification	Supplemental Information
Aperture (selectable)	(frequency span)/(number of points -1)	
Maximum Aperture	20% of frequency span	
Range	0.5 x (1/minimum aperture)	
Maximum Delay		Limited to measuring no more than 180° of phase change within the minimum aperture.)
Accuracy		See graph below. Char.

The following graph shows group delay accuracy with type-N full 2-port calibration and a 10 Hz IF bandwidth. Insertion loss is assumed to be < 2 dB and electrical length to be ten meters.



In general, the following formula can be used to determine the accuracy, in seconds, of specific group delay measurement:

±Phase Accuracy (deg)/[360 × Aperture (Hz)]

Depending on the aperture and device length, the phase accuracy used is either incremental phase accuracy or worst case phase accuracy.

General Information

Table 16. System Bandwidths

Description	Specification	Supplemental Information
IF Bandwidth Sett	ings	
Range		1 Hz to 40 kHz in a 1, 2, 3, 5, 7,10 sequence up to 30 kHz,
		35 kHz, 40kHz, nominal

^a Group delay is computed by measuring the phase change within a specified frequency step (determined by the frequency span and the number of points per sweep).

Table 17. Front Panel Information

Description	Supplemental Information	
RF Connectors		
Туре	Type-N, female; 50 Ω , nominal	
Center Pin Protrusion	0.204 to 0.207 in., characteristic	
Probe Power		
Connector	3-pin connector, male	
Positive Supply	+15 VDC ±2%, 400 mA, max, characteristic	
Negative Supply	-12.6 VDC ±5%, 300 mA, max, characteristic	
Display		
Size	21.3 cm (8.4 in) diagonal color active matrix LCD; 640 (horizontal) X 480 (vertical) resolution	
Refresh Rate	Vertical 59.83 Hz; Horizontal 31.41 Hz	
Display Range	,	
Magnitude	±200 dB (at 20 dB/div), max	
Phase	±180°, max	
Polar	10 pUnits, min	
	1000 Units, max	
Display Resolution		
Magnitude	0.001 dB/div, min	
Phase	0.01°/div, min	
Marker Resolution		
Magnitude	0.001 dB, min	
Phase	0.01°, min	
Polar	0.01 mUnit, min; 0.01°,min	

Table 18. Rear Panel Information

Description Description	Supplemental Information	
10 MHz Reference In		
Connector	BNC, female	
	•	
Input Frequency Input Level	10 MHz ± 1 ppm, typical	
L 1	-15 dBm to +20 dBm, typical	
Input Impedance	200 Ω, nom.	
10 MHz Reference Out	IDNIO (
Connector	BNC, female	
Output Frequency	10 MHz ± 10 ppm, typical	
Signal Type	Sine Wave, typical	
Output Level	+10 dBm ± 4 dB into 50 Ω, typical	
Output Impedance	50 Ω, nominal	
Harmonics	<-40 dBc, typical	
VGA Video Output		
Connector	15-pin mini D-Sub; Drives VGA compatible monitors	
Devices Supported:	Resolutions:	
Flat Panel (TFT)	1024 X 768, 800 X 600, 640 X 480	
Flat Panel (DSTN)	800 X 600, 640 X 480	
CRT Monitor	1280 X 1024, 1024 X 768, 800 X 600, 640 X 480	
	Simultaneous operation of the internal and external displays is allowed, but with 640 X 480 resolution only. If you change resolution, you can only view the external display (internal display will "white out").	
Test Set IO	25-pin D-Sub connector, available for external test set control	
Aux IO	25-pin D-Sub connector, male, analog and digital IO	
Handler IO	36-pin IDC D-ribbon socket connector; all input/output signals are default set to negative logic; can be reset to positive logic via GPIB command	
GPIB	24-pin D-sub (Type D-24), female; compatible with IEEE-488.	
Parallel Port (LPT1)	25-pin D-Sub connector, female; provides connection to printers or any other parallel port peripherals	
Serial Port (COM 1)	9-pin D-Sub, male; compatible with RS-232	
USB Port		
	Universal Serial Bus jack, Type A configuration (4 contacts inline, contact 1 on left); female	
Contact 1	Vcc: 4.75 to 5.25 VDC, 500 mA, maximum	
Contact 2	-Data	
Contact 3	+Data	
Contact 4	Ground	
LAN	10/100BaseT Ethernet, 8-pin configuration; auto selects	
	between the two data rates	
Line Power ^{a, b}		
Frequency at 110/115 V	50/60/400 Hz	
Frequency at 230/240 V	50/60Hz	
Maximum Watts	350 W	
	··	

^a A third-wire ground is required.

Note: Option H08 and Option H11 specifications are not provided in this N3381/2/3A specifications document.

^b Power supply has a voltage autoswitching feature.

Table 19. Rear Panel Information (continued)

Description	Supplemental Information	
External AM Input		
Description	Input provides low-frequency AM modulation to test port output signal, or shifts the test port output. Zero volts input gives the power level set by the instrument, a positive voltage gives a higher level, and a negative voltage gives a lower level.	
Connector	BNC, female	
Input Sensitivity	8 dB/V, typical	
Bandwidth	1 kHz, typical	
Input Impedance	1 k Ω , nominal	
External Detector Input		
Description	Input from an external, negative polarity diode detector provides ALC for a test port remote from instrument's front panel	
Connector	BNC, female	
Input Sensitivity	-500 mV yields approximately -3 dBm at detector's input, typical	
Bandwidth	50 kHz, typical	
Input Impedance	1 k Ω , typical	

Table 20. Analyzer Environment and Dimensions

Description		Supplemental Information		
General Environmental				
RFI/EMI Susceptibility		Defined by CISPR Pub. 1 50082-1	1, Group 1, Class A, and IEC	
ESD		antistatic bench mat	e work procedures and an	
Dust		Minimize for optimum reli	ability	
Operating Environment				
Temperature		0 °C to +40 °C	0 °C to +40 °C	
		Instrument powers up, pherror messages within this	ase locks, and displays no stemperature range.	
Error-Corrected Temperatu	re Range	25°C ± 5°C	ion from calibration temp.	
Humidity		5% to 95% at +40 °C	·	
Altitude		0 to 4500 m (14,760 ft.)		
Non-Operating Storage El	nvironment	·		
Temperature		-40 °C to +70 °C		
Humidity		0% to 90% at +65 °C (no	0% to 90% at +65 °C (non-condensing)	
Altitude		0 to 15,240 m (50,000 ft.)		
Cabinet Dimensions				
	Height	Width	Depth	
Excluding front and rear panel hardware and feet	223 mm 8.75 in	426 mm 16.75 in	427 mm 16.8 in	
As shipped - includes front	1	435 mm	470 mm	
panel connectors, rear panel bumpers, and feet.	9.25 in	17.10 in	18.5 in	
As shipped plus handles	235 mm 9.25 in	458 mm 18 in	501 mm 19.70 in	
As shipped plus rack-	235 mm	483 mm	470 mm	
mount flanges	9.25 in	19 in	18.5 in	
As shipped plus handles	235 mm	483 mm	501 mm	
and flanges	9.25 in	19 in	19.70 in	
Weight				
Net	24 kg (54 lb), nominal			
Shipping	32 kg (70 lb), nominal			

Note: "Misc. Information" specifications are not included in this N3381/2/3A document.

Measurement Throughput Summary

Table 21. Typical Cycle Time^{a,b} (ms)

14510 = 11 1 1 1 1 1 1 1 1				
	Number of	Number of Points		
	101	201	401	1601
Start 1.8 GHz, Sto	p 2 GHz, 35	kHz IF band	width	
Uncorrected, 1-port cal	8	11	17	53
2-Port cal	27	36	55	164
Start 300 kHz, Sto	Start 300 kHz, Stop 3 GHz, 35 kHz IF bandwidth			
Uncorrected, 1-port cal	48	54	64	104
2-Port cal	103	119	145	254
Start 300 kHz, Stop 9 GHz, 35 kHz IF bandwidth				
Uncorrected, 1-port cal	45	55	61	99
2-Port cal	99	119	133	212

a Typical performance.

Table 22. Cycle Time vs. IF Bandwidth^a

Applies to the Preset condition (201 points, correction off) except for the following changes:

- CF = 1 GHz
- Span = 100 MHz
- Display off (add 21 ms for display on)

IF	Cycle Time
Bandwidth	(ms) ^b
(Hz)	
40,000	8
35,000	9
30,000	11
20,000	13
10,000	28
7000	36
5000	48
3000	72
1000	196
300	620
100	1875
30	8062
10	17877

b Includes sweep time, retrace time and band-crossing time. Analyzer display turned off with DISPLAY:ENABLE OFF. Add 21 ms for display on. Data for one trace (S11) measurement.

c Option 010 only. Analyzer display turned off with DISPLAY:ENABLE OFF. Add 21 ms for display on. Data for one trace (S11) measurement.

^a Typical performance. ^b Cycle time includes sweep and retrace time.

Table 23. Cycle Time vs. Number of Points^a

Applies to the Preset condition (35 kHz IF bandwidth, correction off) except for the following changes:

- CF = 1 GHz
- Span = 100 MHz
- Display off (add 21 ms for display on)

Number of Points	Cycle Time (ms) ^b
3	4
11	4
51	5
101	6
201	9
401	16
801	29
1601	52

^a Typical performance.
^b Cycle time includes sweep and retrace time.

Table 24. Data Transfer Timea (ms)

	Number of Points						
	51	201	401	1601			
SCPI over GPIB							
(program executed on external PC) ^b							
32-bit floating point	3	7	12	43			
64-bit floating point	4	12	22	84			
ASCII	7	64	124	489			
SCPI over 100 Mbit/s LAN							
(program executed on external PC) ^b							
32-bit floating point	1	1	1	1			
64-bit floating point	1	1	1	2			
ASCII	5	15	26	96			
SCPI (program executed in the analyzer) ^d							
32-bit floating point	1	1	2	3			
64-bit floating point	1	2	2	4			
ASCII	8	29	56	222			
COM (program executed in the analyzer) ^e							
32-bit floating point	1	1	1	1			
Variant type	1	1	2	6			
DCOM over 100 Mbit/s LAN							
(program executed on external PC) ^f							
32-bit floating point ⁹	1	1	1	2			
Variant type ⁿ	1	3	6	19			

Typical performance of unit with 500 MHz Pentium III processor.
 Measured using a VEE 5.0 program running on a 600 MHz HP Kayak, National InstrumentsTM GPIB card.
 Transferred complex S11 data, using "CALC:DATA?SDATA".

^c Measured using a VEE 5.0 program running on a 600 MHz HP Kayak. Transferred complex S11 data, using "CALC:DATA?SDATA". Speed dependent on LAN traffic, if connected to network.

d Measured using a VEE 5.0 program running inside PNA Series Analyzer. Transferred complex S11 data, using "CALC:DATA?SDATA".

e Measured using a Visual Basic 6.0 program running inside PNA Series Analyzer. Transferred complex S11

^f Measured using a Visual Basic 6.0 program running on a 600 MHz HP Kayak. Transferred complex S11 data. Speed dependent on LAN traffic, if connected to network.

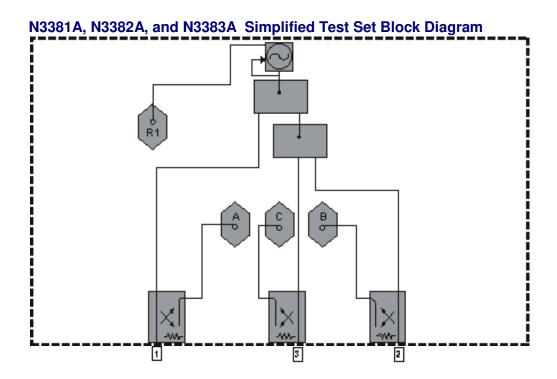
⁹ Used IArray Transfer.getComplex method for 32-bit floating point.

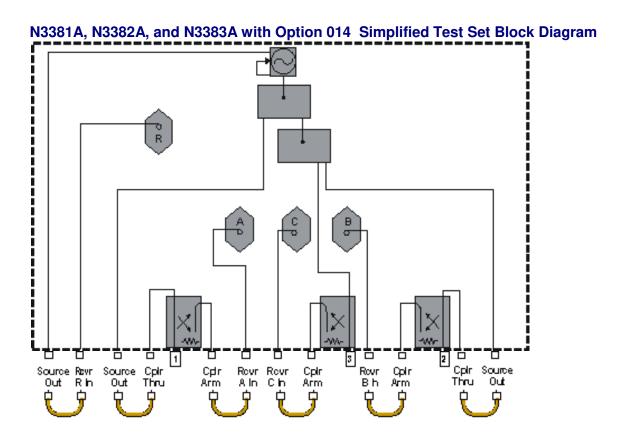
^h Used meas.getData method for Variant data type.

Table 25. Recall and Sweep Speed^a

Operations	Number of	Number of	Recall
	Window(s)	Trace(s)	Time (ms)
Recall	1	1	49
Recall and Sweep	1	1	59
Recall	1	2	82
Recall and Sweep	1	2	96
Recall	1	4	159
Recall and Sweep	1	4	203
Recall	2	2	93
Recall and Sweep	2	2	115
Recall	3	4	158
Recall and Sweep	3	4	218
Recall	4	4	187
Recall and Sweep	4	4	247
			<u> </u>
Recall	4	8	340
Recall and Sweep	4	8	507

aCF=177MHz, Span=200 MHz, 201 points, 35 kHz IF BW







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